Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/763,672	ISHII ET AL.		
Examiner	Art Unit		
Tuyen Q. Tra	2873		

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Class	Subclass	Date	Examiner
359	290 291 292 295 223 224 245 248	5/16/2005	т.т,
359	320 332	5/16/2005	T.T.
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INI	ITERFERENCE SEARCHED		
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